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STW19NM60N

Datasheet - production data

Automotive-grade N-channel 600 V, 0.26 Ω typ., 13 A MDmesh[™] II Power MOSFET in a TO-247 package

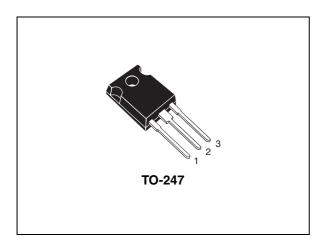
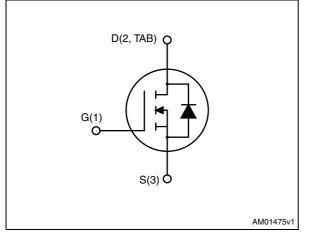


Figure 1. Internal schematic diagram



Features

Order code	V _{DS} (@T _{jmax})	R _{DS(on)} max.	I _D	P _{TOT}
STW19NM60N	650 V	0.285 Ω	13 A	110 W

- Designed for automotive applications and AEC-Q101 qualified
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

Applications

• Switching applications

Description

This device is an N-channel Power MOSFET developed using the second generation of MDmesh[™] technology. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STW19NM60N	19NM60N	TO-247	Tube

DocID024392 Rev 2

This is information on a product in full production.

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	600	V
V_{GS}	Gate- source voltage	± 25	
۱ _D	Drain current (continuous) at $T_{C} = 25 \ ^{\circ}C$	13	A
I _D	Drain current (continuous) at $T_C = 100 \ ^{\circ}C$	8.2	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	52	A
P _{TOT}	Total dissipation at $T_{C} = 25 \text{ °C}$	110	W
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_J max)	4	A
E _{AS}	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}, I_D = I_{AR}, V_{DD} = 50 \text{ V}$)	350	mJ
dv/dt ⁽²⁾	Peak diode recovery voltage slope	15	V/ns
Т _Ј	Operating junction temperature	-55 to 150	°C
T _{stg}	Storage temperature	-35 10 150	°C

1. Pulse width limited by safe operating area.

2. $I_{SD} \leq$ 13 A, di/dt \leq 400 A/µs, $V_{DD} \leq$ 80 % $V_{(BR)DSS}$, $V_{DS(peak)} \leq V_{(BR)DSS}$

Symbol Parameter		Value	Unit
R _{thj-case}	Thermal resistance junction-case max	1.14	°C/W
R _{thj-amb}	Thermal resistance junction-amb max	50	°C/W



2 Electrical characteristics

(T_{CASE}=25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	600			v
Zero gate voltage drain	V _{DS} = 600 V			1	μΑ	
'DSS	I_{DSS} current ($V_{GS} = 0$)	V _{DS} = 600 V, T _J =125 °C			10	μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±25 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D =6.5 A		0.260	0.285	Ω

Table 4. On/off states

Table 5. Dynamic

······						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1000	-	pF
C _{oss}	Output capacitance	V _{DS} = 50 V, f =1 MHz,	-	60	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	3	-	pF
C _{oss eq.} ⁽¹⁾	Output equivalent capacitance	$V_{DS} = 0$, to 480 V, $V_{GS} = 0$	-	225	-	pF
R _g	Intrinsic resistance	f=1 MHz open drain	-	3.5	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 13 A	-	35	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	6	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15)	-	20	-	nC

1. $C_{oss eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DS} .



	Table 0. Switching times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 6.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 14)	-	12	-	ns	
t _r	Rise time		-	15	-	ns	
t _{d(off)}	Turn-off delay time		-	55	-	ns	
t _f	Fall time		-	25	-	ns	

Table 6. Switching times

Table 7. Source drain diode

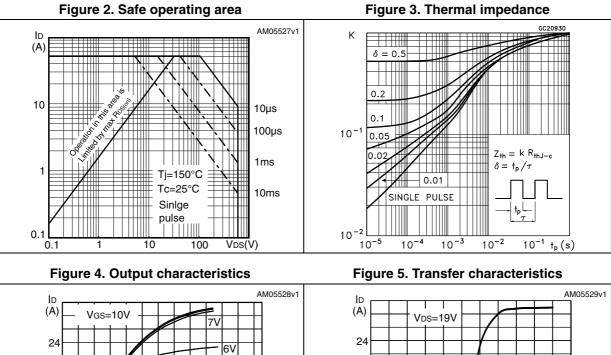
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		13	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		52	А
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 13 A, V _{GS} =0	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} =13 A, di/dt =100 A/µs, V _{DD} = 60 V (<i>see Figure 16</i>)	-	300		ns
Q _{rr}	Reverse recovery charge		-	4.0		μC
I _{RRM}	Reverse recovery current		-	25		А
t _{rr}	Reverse recovery time	V _{DD} = 60 V di/dt =100 A/µs, I _{SD} = 13 A Tj = 150°C <i>(see Figure 16)</i>	-	360		ns
Q _{rr}	Reverse recovery charge		-	4.5		μC
I _{RRM}	Reverse recovery current		-	25		А

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)



20

16

12

8

4

0

0

2

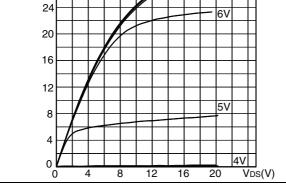


Figure 6. Static drain-source on-resistance

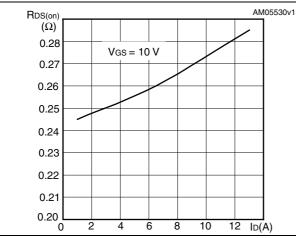


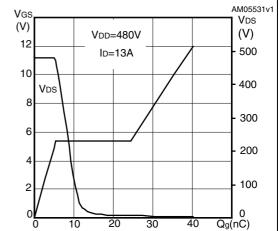
Figure 7. Gate charge vs gate-source voltage

4

6

8

10 VGs(V)





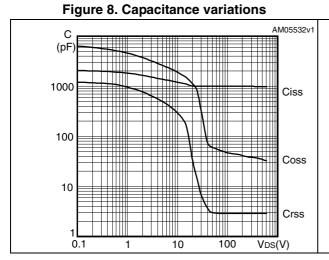


Figure 10. Normalized gate threshold voltage vs temperature

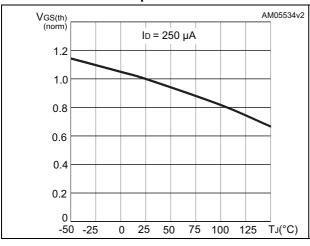


Figure 12. Normalized V_{DS} vs temperature

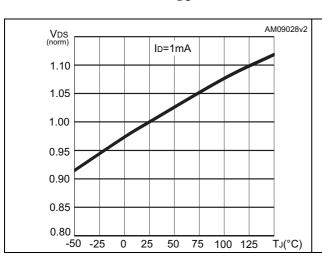


Figure 9. Output capacitance stored energy

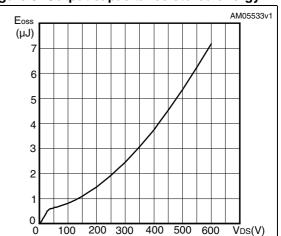


Figure 11. Normalized on-resistance vs temperature

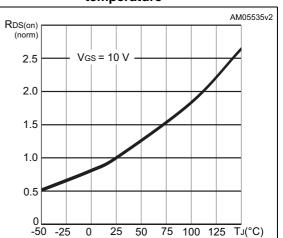
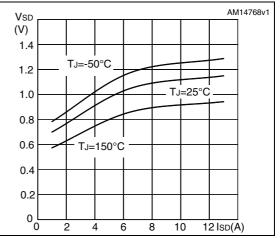


Figure 13. Source-drain diode forward vs temperature





3 Test circuits

Figure 14. Switching times test circuit for resistive load

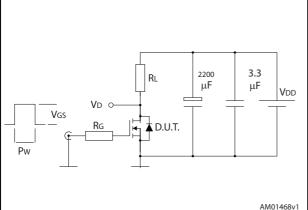


Figure 16. Test circuit for inductive load switching and diode recovery times

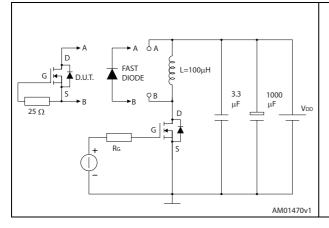


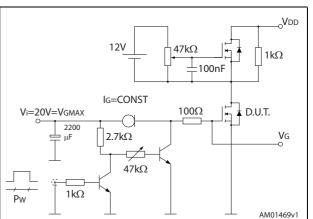
Figure 18. Unclamped inductive waveform

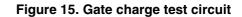
VD

IDM

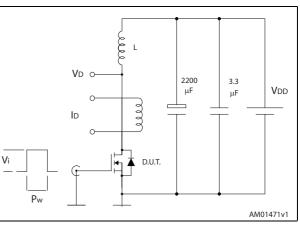
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V(BR)DSS









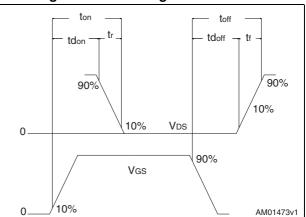


Figure 19. Switching time waveform

Vdd

AM01472v1



Vdd

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

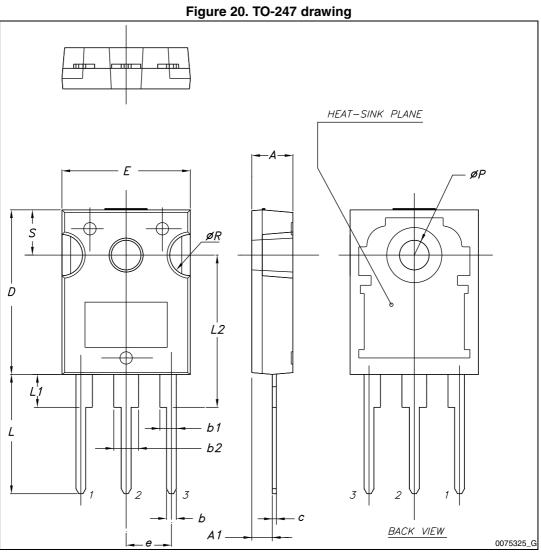


Table 8. 10-247 mechanical data					
Dim.		mm.			
Dini.	Min.	Тур.	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
E	15.45		15.75		
е	5.30	5.45	5.60		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
ØP	3.55		3.65		
ØR	4.50		5.50		
S	5.30	5.50	5.70		

Table 8. TO-247 mechanical data









5 Revision history

Date	Revision	Changes
21-Mar-2013	1	Initial release.
24-Oct-2013	2	 Modified: title, features and applications Minor text changes

Table 9. Document revision history



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